

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/608,493	PARK ET AL.	
Examiner		Art Unit		Page 1 of 1
Thuy V. Tran		2821		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0001828 A1	01-2003	Asano, Mitsuru	345/204
*	B	US-2002/0195964 A1	12-2002	Yumoto, Akira	315/169.3
*	C	US-6,731,276	05-2004	Ishizuka, Shinichi	345/211
*	D	US-6,448,718	09-2002	Battersby, Stephen J.	315/169.3
*	E	US-6,271,812	08-2001	Osada et al.	345/76
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.